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FDS6630A

# N-Channel Logic Level PowerTrench™ MOSFET

## **General Description**

This N-Channel Logic Level MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

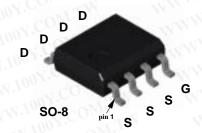
These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

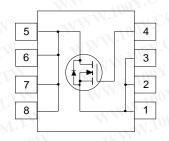
## **Applications**

- DC/DC converter
- Load switch
- Motor drives

## **Features**

- 6.5 A, 30 V.  $R_{DS(on)} = 0.038 \ \Omega \ @ V_{GS} = 10 \ V$   $R_{DS(on)} = 0.053 \ \Omega \ @ V_{GS} = 4.5 \ V$
- Low gate charge (5nC typical).
- Fast switching speed.
- $\bullet$  High performance trench technology for extremely low  $R_{\mbox{\tiny DS(ON)}}.$
- High power and current handling capability.





Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	100Y.CO	Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage	1100X.C	30	110V
V <sub>GSS</sub>	Gate-Source Voltage	M. CC	<u>+</u> 20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	6.5	A
	- Pulsed	, 100 x	40	W.100
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	2.5	W
	MAN. Too COM.	(Note 1b)	1.2	
	W.1001. COM:11.	(Note 1c)	CONL	7.1/W.T.
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range		-55 to +150	∘C

# **Thermal Characteristics**

$R_{\theta^{JA}}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R <sub>OJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

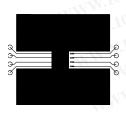
Package Outlines and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
FDS6630A	FDS6630A	13"	12mm	2500 units

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Symbol	Parameter	Test Conditions		Typ	Max	Units
Off Char	acteristics	MATTIN M. TOOL	1.1	Ŋ	•	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$				V
ABVDSS ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C	OM.T	24		mV/∘C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	$M_{\rm O}$	X	1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	- 01	IN	100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$	Co.	TI	-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250  \mu A$	1C	1.7	3	V
<u>A</u> VGS(th) ΛΤυ	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$ , Referenced to 25°C	00X.C	0-4	TW	mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}, T_J = 125 ^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}$	100X	0.028 0.044 0.040	0.038 0.060 0.053	Ω
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$		-1 CO	M·	Α
<b>g</b> FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 6.5 \text{ A}$	x 10	13	T.Mc	S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$		460		pF
Coss	Output Capacitance	f = 1.0 MHz	WW.	115	$CO_{j_{1}}$	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	20 T. COM. IV		45	- COI	pF
Switchin	ng Characteristics (Note 2)	100Y. OM.TW	N N N	N.100	y	M.T.
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, I_{D} = 1 \text{ A},$	W	5	11	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	W	8	17	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	N.100 COM.	- T	17	28	ns
t <sub>f</sub>	Turn-Off Fall Time	W.100 Y. COM. TW	- 1	13	24	ns
$\overline{Q_g}$	Total Gate Charge	$V_{DS} = 5 \text{ V}, I_{D} = 6.5 \text{ A},$	V	5	7	nC
$Q_{gs}$	Gate-Source Charge	$V_{GS} = 5 \text{ V}$		2	- 100	nC
$Q_{qd}$	Gate-Drain Charge	MM. Ing COM.		0.9	M.	nC
1	ource Diede Characteristics on	d Maximum Patings		-11	M.10	~ C
<u>Drain-Sc</u> I <sub>s</sub>	Durce Diode Characteristics and Maximum Continuous Drain-Source Did		-		2.1	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.1 \text{ A} \text{ (Note 2)}$	N	0.8	1.2	V

<sup>1:</sup> R<sub>BJA</sub> is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 50° C/W when mounted on a 1 in2 pad of 2 oz. copper.



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mounted on a 0.04 in<sup>2</sup> pad of 2 oz. copper.



c) 125° C/W on a 0.006 in2 pad of 2 oz. copper.

Scale 1: 1 on letter size paper

2: Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%

# **Typical Characteristics**

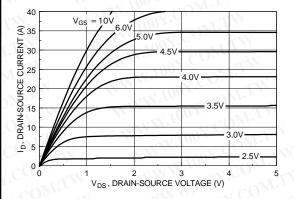


Figure 1. On-Region Characteristics.

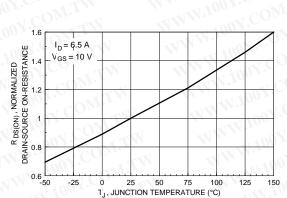


Figure 3. On-Resistance Variation with Temperature.

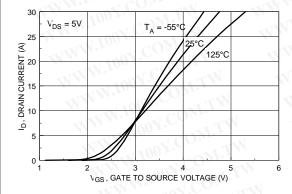


Figure 5. Transfer Characteristics.

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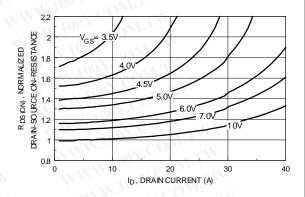


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

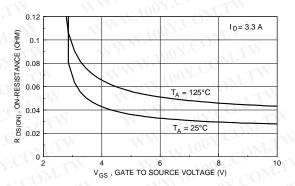


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

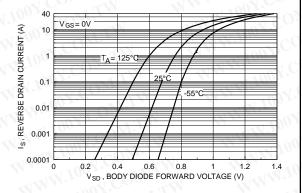
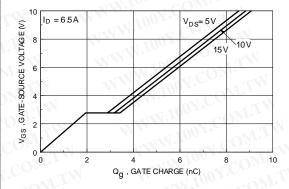


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# Typical Characteristics (continued)



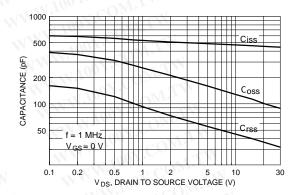
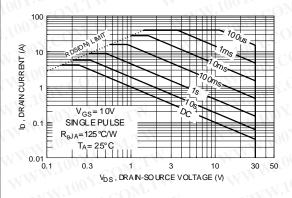


Figure 7. Gate-Charge Characteristics.





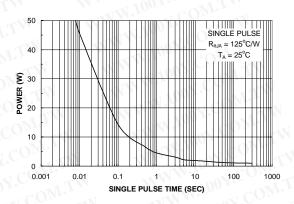


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

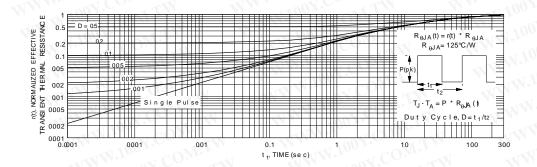


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient themal response will change depending on the circuit board design.

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